

Description

The series of devices uses **Super Trench II** technology that is uniquely optimized to provide the most efficient high frequency switching performance. Both conduction and switching power losses are minimized due to an extremely low combination of $R_{DS(ON)}$ and Q_g . This device is ideal for high-frequency switching and synchronous rectification.

Application

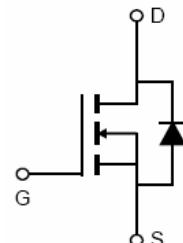
- DC/DC Converter
- Ideal for high-frequency switching and synchronous rectification

General Features

- $V_{DS} = 85V, I_D = 80A$
- $R_{DS(ON)} = 7.5m\Omega$, typical @ $V_{GS} = 10V$
- Excellent gate charge x $R_{DS(on)}$ product(FOM)
- Very low on-resistance $R_{DS(on)}$
- 175 °C operating temperature
- Pb-free lead plating



TO-220C



Schematic Diagram

Package Marking and Ordering Information

| Device Marking | Device | Device Package | Reel Size | Tape width | Quantity |
|----------------|-----------|----------------|-----------|------------|----------|
| VST08N075-TC | VST08N075 | TO-220C | - | - | - |

Absolute Maximum Ratings ($T_c=25^\circ C$ unless otherwise noted)

| Parameter | Symbol | Limit | Unit |
|---|---------------------|------------|------|
| Drain-Source Voltage | V_{DS} | 85 | V |
| Gate-Source Voltage | V_{GS} | ± 20 | V |
| Drain Current-Continuous | I_D | 80 | A |
| Drain Current-Continuous($T_c=100^\circ C$) | $I_D (100^\circ C)$ | 60 | A |
| Pulsed Drain Current | I_{DM} | 320 | A |
| Maximum Power Dissipation | P_D | 100 | W |
| Derating factor | | 0.67 | W/°C |
| Single pulse avalanche energy ^(Note 4) | E_{AS} | 352 | mJ |
| Operating Junction and Storage Temperature Range | T_J, T_{STG} | -55 To 175 | °C |

Thermal Characteristic

| | | | |
|--------------------------------------|-----------------|-----|------|
| Thermal Resistance, Junction-to-Case | $R_{\theta JC}$ | 1.5 | °C/W |
|--------------------------------------|-----------------|-----|------|

Electrical Characteristics ($T_c=25^\circ\text{C}$ unless otherwise noted)

| Parameter | Symbol | Condition | Min | Typ | Max | Unit |
|---|----------------------------|---|-----|------|----------|------------------|
| Off Characteristics | | | | | | |
| Drain-Source Breakdown Voltage | BV_{DSS} | $\text{V}_{\text{GS}}=0\text{V}, \text{I}_D=250\mu\text{A}$ | 85 | - | - | V |
| Zero Gate Voltage Drain Current | I_{DSS} | $\text{V}_{\text{DS}}=85\text{V}, \text{V}_{\text{GS}}=0\text{V}$ | - | - | 1 | μA |
| Gate-Body Leakage Current | I_{GSS} | $\text{V}_{\text{GS}}=\pm20\text{V}, \text{V}_{\text{DS}}=0\text{V}$ | - | - | ±100 | nA |
| On Characteristics (Note 3) | | | | | | |
| Gate Threshold Voltage | $\text{V}_{\text{GS(th)}}$ | $\text{V}_{\text{DS}}=\text{V}_{\text{GS}}, \text{I}_D=250\mu\text{A}$ | 2.0 | 3.0 | 4.0 | V |
| Drain-Source On-State Resistance | $\text{R}_{\text{DS(ON)}}$ | $\text{V}_{\text{GS}}=10\text{V}, \text{I}_D=40\text{A}$ | - | 7.5 | 8.0 | $\text{m}\Omega$ |
| Forward Transconductance | g_{FS} | $\text{V}_{\text{DS}}=5\text{V}, \text{I}_D=40\text{A}$ | | 50 | - | S |
| Dynamic Characteristics (Note 3) | | | | | | |
| Input Capacitance | C_{iss} | $\text{V}_{\text{DS}}=40\text{V}, \text{V}_{\text{GS}}=0\text{V},$ $F=1.0\text{MHz}$ | - | 2059 | - | pF |
| Output Capacitance | C_{oss} | | - | 393 | - | pF |
| Reverse Transfer Capacitance | C_{rss} | | - | 25.4 | - | pF |
| Switching Characteristics (Note 3) | | | | | | |
| Turn-on Delay Time | $t_{\text{d(on)}}$ | $\text{V}_{\text{DD}}=40\text{V}, \text{I}_D=40\text{A}$ $\text{V}_{\text{GS}}=10\text{V}, \text{R}_G=1.6\Omega$ | - | 12 | - | nS |
| Turn-on Rise Time | t_r | | - | 9 | - | nS |
| Turn-Off Delay Time | $t_{\text{d(off)}}$ | | - | 29 | - | nS |
| Turn-Off Fall Time | t_f | | - | 7 | - | nS |
| Total Gate Charge | Q_g | $\text{V}_{\text{DS}}=40\text{V}, \text{I}_D=40\text{A},$ $\text{V}_{\text{GS}}=10\text{V}$ | - | 41.4 | - | nC |
| Gate-Source Charge | Q_{gs} | | - | 14.9 | - | nC |
| Gate-Drain Charge | Q_{gd} | | - | 12.5 | - | nC |
| Drain-Source Diode Characteristics | | | | | | |
| Diode Forward Voltage (Note 2) | V_{SD} | $\text{V}_{\text{GS}}=0\text{V}, \text{I}_s=40\text{A}$ | - | - | 1.2 | V |
| Diode Forward Current | I_s | | - | - | 80 | A |
| Reverse Recovery Time | t_{rr} | $T_J = 25^\circ\text{C}, I_F = 40\text{A}$ $dI/dt = 100\text{A}/\mu\text{s}$ (Note 3) | - | 55 | - | nS |
| Reverse Recovery Charge | Q_{rr} | | - | 98 | - | nC |

Notes:

1. Repetitive Rating: Pulse width limited by maximum junction temperature.
2. Pulse Test: Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$.
3. Guaranteed by design, not subject to production
4. EAS condition : $T_J=25^\circ\text{C}, V_{\text{DD}}=50\text{V}, V_G=10\text{V}, L=0.25\text{mH}, R_g=25\Omega$

Typical Electrical and Thermal Characteristics

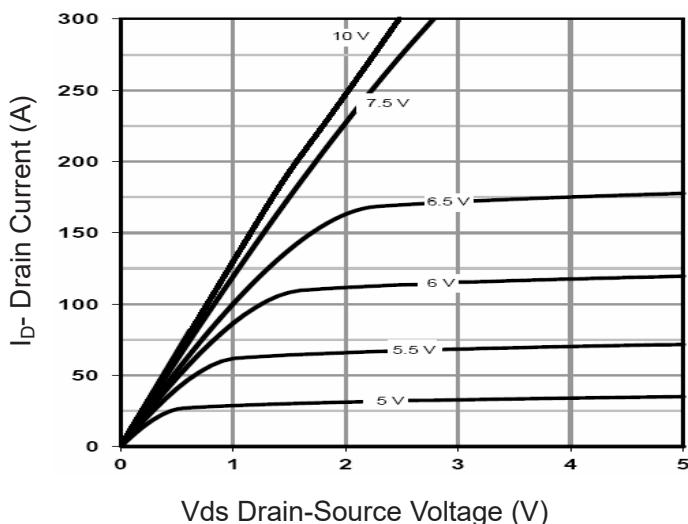


Figure 1 Output Characteristics

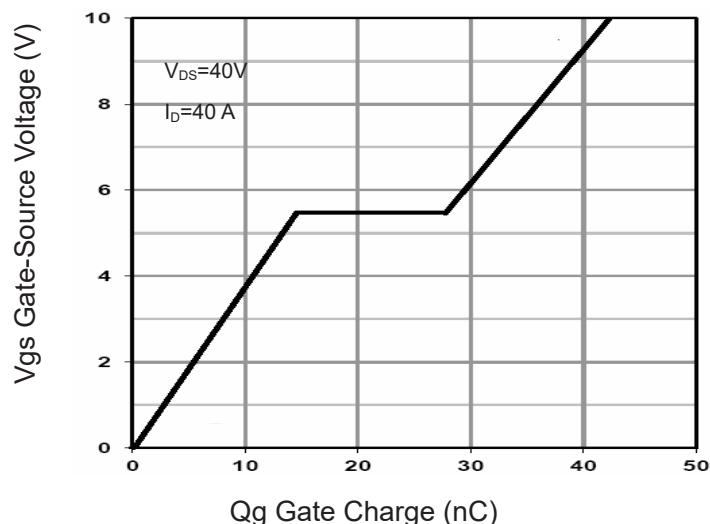


Figure 4 Gate Charge

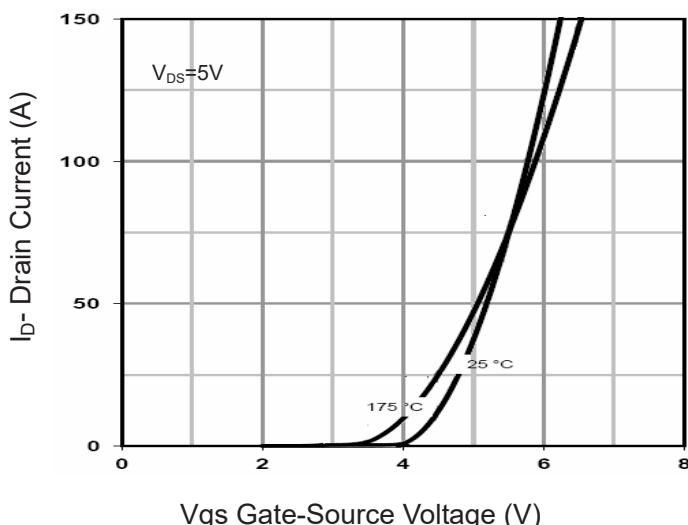


Figure 2 Transfer Characteristics

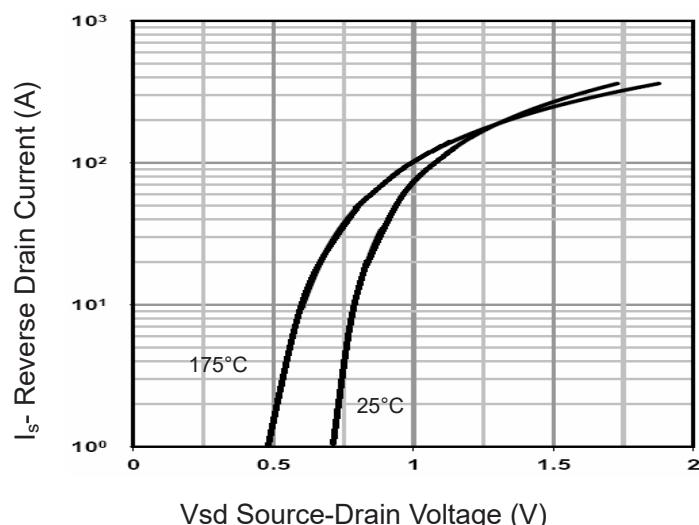


Figure 5 Source- Drain Diode Forward

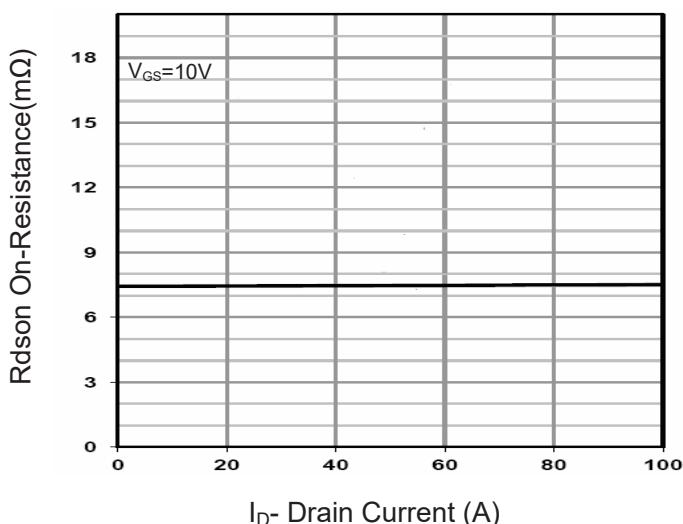


Figure 3 Rdson- Drain Current

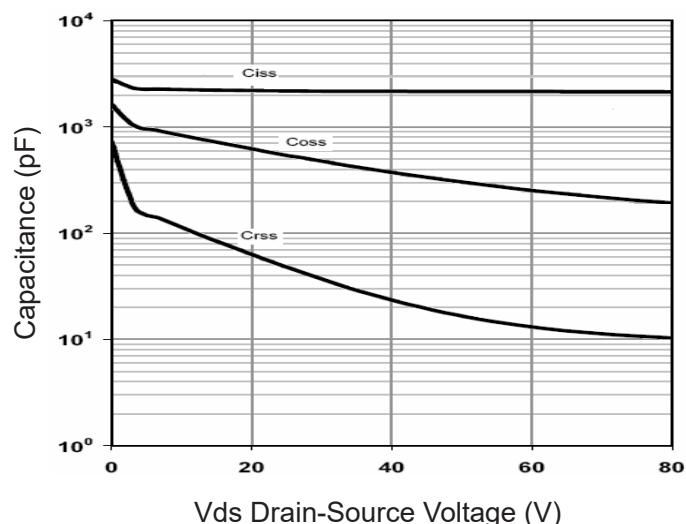
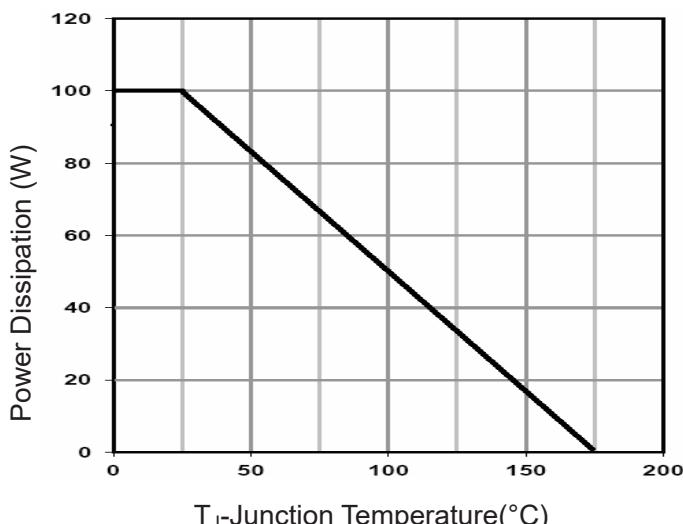
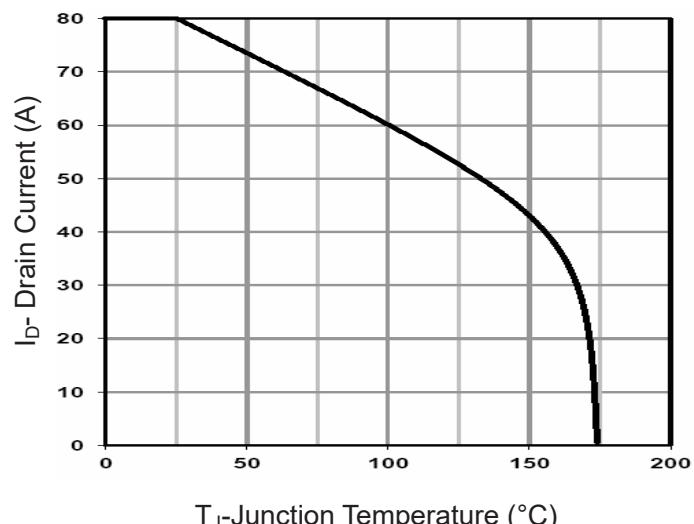
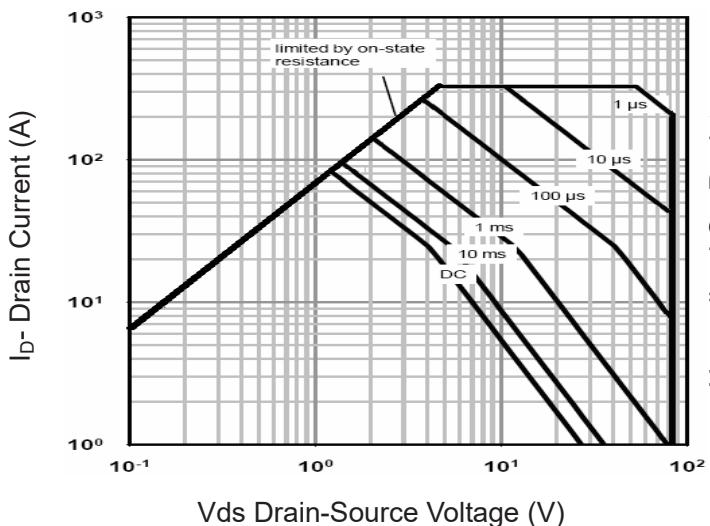
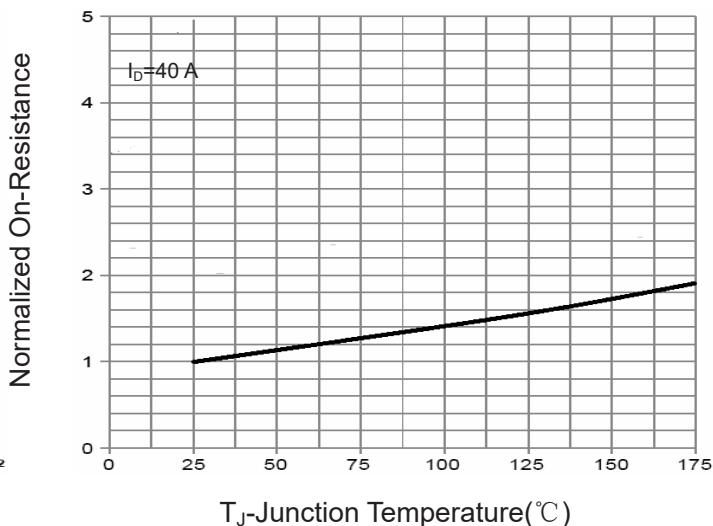
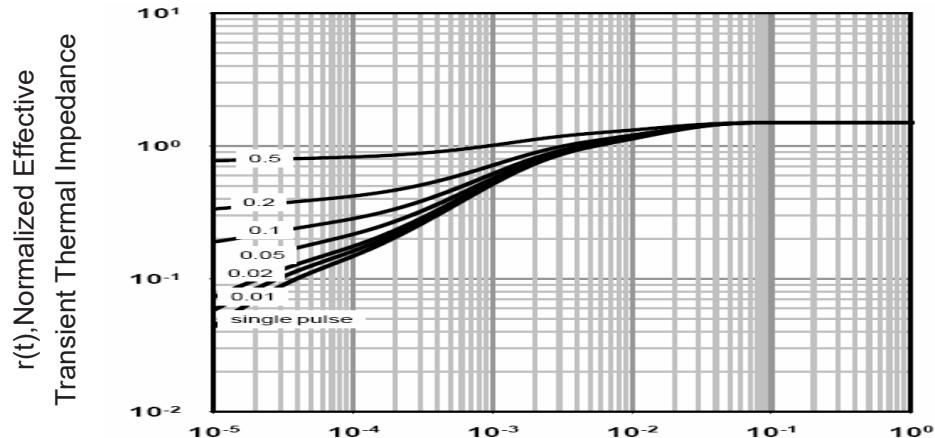


Figure 6 Capacitance vs Vds


Figure 7 Power De-rating

Figure 9 Current De-rating

Figure 8 Safe Operation Area

Figure 10 Rdson-Junction Temperature

Figure 11 Normalized Maximum Transient Thermal Impedance